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Ultrafast pump-probe force microscopy with nanoscale resolution

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We perform time-resolved pump-probe microscopy measurements by recording the local force between a sharp tip and the photo-excited sample as a readout mechanism for the material's nonlinear polarization. We show that the photo-induced force is sensitive to the same excited state dynamics as measured in an optical pump-probe experiment. Ultrafast pump-probe force microscopy constitutes a non-optical detection technique with nanoscale resolution that pushes pump-probe sensitivities close to the realm of single molecule studies. © 2015 AIP Publishing LLC.

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Optical pump-probe spectroscopy comprises a popular set of techniques that enables a direct view of the time-ordered, ultrafast dynamics following optical excitations in materials.¹ Pump-probe measurements are typically carried out on large ensembles of particles or molecules, where the response of individual contributors combines with that from others to produce strong optical signals from the illuminated sample. In many studies, however, the sample is heterogeneous, and the unique response from individual particles is lost when averaging over the ensemble.

The ability to perform pump-probe measurements of single particles relies on technological advances that give rise to detectable signals from increasingly smaller ensembles of optical responders. Focusing light to diffraction-limited volumes, which is the excitation geometry used in various forms of pump-probe microscopy, increases the sensitivity to sub-micrometer scale particles.²⁻⁴ The far-field optical microscope is sensitive enough for enabling pump-probe measurements of nanostructures with large optical cross sections, including metal nanoparticles,⁵ semiconducting quantum dots,⁶ and carbon nanotubes.⁷

Using optical excitation in combination with scanning probe techniques offers an opportunity to perform pump-probe measurements at sub-diffraction limited resolution, which can further increase the sensitivity of the measurement.^{8,9} Recent examples of near-field pump-probe microscopy studies include ultrafast exciton dynamics in single quantum dots¹⁰ and molecular nanocrystals,¹¹ and time-resolved plasmonic dynamics in graphene.¹² However, pushing the sensitivity of these techniques to the level of single molecules is challenging. Optical detection of the pump-probe effect is not background free: it relies on the ability to register a pump-induced intensity change in the scattered probe radiation. In the single molecule limit, despite recent successes,¹³ the induced gain or loss in the probe detection channel may be well below the experimental shot noise. In

this regard, detection strategies that circumvent the deleterious effects of the large optical background in nonlinear pump-probe measurements would be highly desirable.

Non-optical detection strategies offer a promising alternative for detecting the pump-probe response on the nanoscale. A particularly attractive approach is photo-induced force microscopy (PiFM). It has recently been shown that PiFM can detect optical transitions in chromophores by registering the changes in the electromagnetic forces between an atomically sharp tip and the sample.¹⁴ The gradient force between the light-induced dipoles in the tip and molecule is a sensitive function of the molecule's polarizability, and thus offers a mechanism for nanoscale spectroscopy based on non-contact force detection.^{15,16} PiFM is capable of probing various forms of optical interactions, including nonlinear optical excitation of the material, as recently demonstrated in force detection of stimulated Raman scattering in molecules using cw laser illumination.¹⁷

In this work, we show that the ultrafast excitation dynamics of a molecular chromophore can be monitored in a non-optical manner through time-resolved (tr-)PiFM. This approach enables sub-diffraction limited measurements on the 10 nm scale with a time resolution defined by the temporal width of the femtosecond pump and probe laser pulses. We demonstrate that the tr-PiFM signal is sensitive to the same excited state dynamics probed in far-field optical pump-probe measurements. A non-optical detection technique, tr-PiFM suppresses the impact of the optical background that is intrinsic to conventional optical pump-probe techniques, and offers a viable route for improving the detection sensitivity down to the single molecule limit.

The basic layout of the tr-PiFM experiment is shown in Figure 1. Two fs laser beams—a pump beam at frequency ω_1 and a probe beam at frequency ω_2 —are incident on a microscope objective. The pump and probe beams are focused to a diffraction limited spot and optically excite the sample. A cantilevered, gold coated, scanning probe microscope tip is positioned in the focal spot forming a tip-

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and decays exponentially with a lifetime of $\tau_1 = 7.9$ ps. Beyond a probe wavelength of ~ 700 nm, the signal reverses sign, an indication of ground state depletion.

We next examine the pump-probe response of SiNc at the nanoscale using tr-PiFM. The sample consists of SiNc nanoclusters, which vary in size between several micrometers to less than 10 nm in diameter, spin cast from solution onto a borosilicate coverslip. Figure 3 depicts images of sub-100 nm SiNc nanoclusters taken at two different time delays and the probe wavelength tuned to 605 nm, where we expect a strong excited state absorption. The left column shows the topography (3(a)) and PiFM (3(c)) images when the time delay is set to -5.9 ps. Whereas the topography image indicates the presence of multiple clusters, the PiFM image, measured at Δf , displays limited contrast. The situation changes when the pump-probe time delay is tuned to 0.7 ps. As expected, the topography image (3(b)) remains unaltered upon changing the time delay. The PiFM image (3(d)), however, changes dramatically and now clearly reveals the SiNc structures. The PiFM signal at positive time delays indicates the presence of a force modulated at Δf , as induced by the joint action of the pump and probe pulses.

Note that unlike the topography image, which shows nanoscale height variations among the clusters, the signal magnitude in the PiFM image is nearly uniform. This response is expected from the spectroscopically sensitive

gradient force, which is a local force that is exclusively manifested at nm distances from the surface and relatively independent of volume effects.¹⁶ In addition to larger clusters, Figure 3(d) shows smaller structures down to a width of ~ 10 nm, which corresponds to the spatial resolution of the PiFM microscope. Under the excitation conditions used, the magnitude of the photo-induced pump-probe signal at zero time delay is ~ 500 μ V, which translates into a force of 370 pN. When either of the optical beams is blocked, the signal is reduced to less than 5 μ V, which is also the background signal in the absence of light.

In order to further investigate the pump-probe signature in tr-PiFM, we record images of a single cluster at various positive time delays. The magnitude of the photo-induced force is shown by the solid dots in Figure 3(e), revealing that the tr-PiFM signal decays on the picosecond timescale. The tr-PiFM signal is compared with the time-resolved pump-probe signal of a larger cluster, using far-field optical detection in the same microscope. It can be clearly seen that the force-detected signal and the optically detected signal display the same dynamics: they both decay with the excited state lifetime of the S_1 state in SiNc.

This work demonstrates the feasibility of probing the ultrafast nonlinear optical response of nanoscopic materials in a non-optical manner by measuring changes in the local forces between a sharp tip and the sample. The PiFM approach can be used to examine various pump-probe transitions in the material, as shown here for excited state absorption, at a resolution far below the diffraction limit of light. Because the sensitivity in PiFM is not primarily limited by the large optical background that affects the sensitivity of conventional optical pump-probe measurements, the technique represents an attractive means of interrogating the nonlinear optical properties of small quantities of molecules. This work shows pump-probe PiFM signals from molecular assemblies as small as 10 nm, which is near the resolution of the microscope. Further optimization may push the sensitivity well into the limit of individual chromophores, setting the stage for a wide array of single molecule ultrafast spectroscopy studies at the nm/fs space-time resolution.

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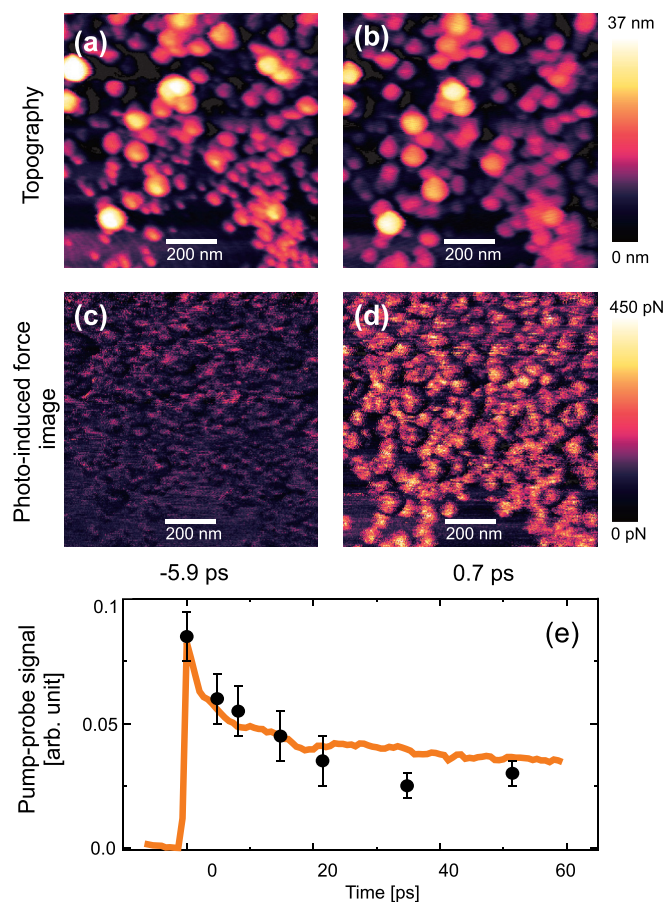


FIG. 3. Topography image (a) (or (b)) and optical force image (c) (or (d)) are simultaneously recorded at negative time delay -5.9 ps (or positive time delay 0.7 ps). (e) direct comparison between the optically detected pump-probe signal (orange solid line) and the tr-PiFM signal (black circle dots).

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